

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/589,492	MIZUKURA ET AL.	
Examiner		Art Unit		Page 1 of 1
Dwight Alex C. Tejano		4112		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0215132	11-2003	Kagawa et al.	382/162
*	B	US-2004/0174389	09-2004	Ben-David et al.	345/694
*	C	US-5,889,554	03-1999	Mutze, Ulrich	348/273
*	D	US-4,833,527	05-1989	Kondo, Toshiharu	348/675
*	E	US-5,280,347	01-1994	Shiraishi et al.	348/223.1
*	F	US-6,434,268	08-2002	Asamura et al.	382/162
*	G	US-7,418,129	08-2008	Komori, Yoko	382/162
*	H	US-2007/0132864	06-2007	Tsuruoka, Takao	348/241
*	I	US-4,907,074	03-1990	Hashimoto, Seiji	348/237
*	J	US-7,148,925	12-2006	Osada et al.	348/275
*	K	US-7,057,654	06-2006	Roddy et al.	348/277
*	L	US-2006/0038953	02-2006	Moriya, Hidekuni	349/144
*	M	US-5,568,193	10-1996	Kawahara, Norihiro	348/222.1

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.